

<b>Notice of References Cited</b>	Application/Control No. 10/566,433		Applicant(s)/Patent Under Reexamination MUKAI ET AL.	
	Examiner Jessee Roe		Art Unit 1793	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,910,379	06-1999	Kasashima et al.	429/59
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Takeshita, T., "Low-temperature heat-capacity study of Haucke compounds CaNi <sub>5</sub> , YNi <sub>5</sub> , LaNi <sub>5</sub> , and ThNi <sub>5</sub> ", Physical Review B, Volume 21, Number 12, 15 June 1980, pp. 5636-5641.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.